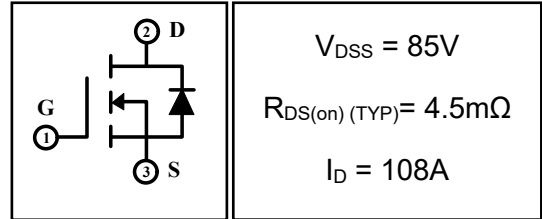


# 108A 85V N-channel Enhancement Mode Power MOSFET

## 1 Description

These N-channel enhancement mode power mosfets used advanced split gate trench technology design, provided excellent  $R_{DS(on)}$  and low gate charge. Which accords with the RoHS standard.

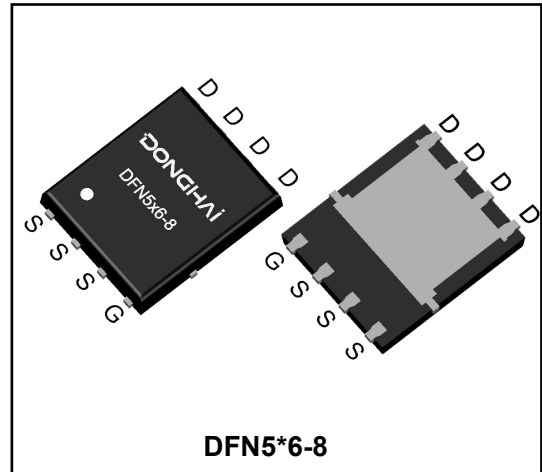


## 2 Features

- Fast switching
- Low on resistance
- Low gate charge
- High avalanche current
- Low reverse transfer capacitances
- 100% single pulse avalanche energy test
- 100%  $\Delta V_{DS}$  test

## 3 Applications

- Synchronous rectification in SMPS
- Hard switching and high speed circuit
- Power tools
- UPS
- Motor control



## 4 Electrical Characteristics

### 4.1 Absolute Maximum Ratings (Tc=25°C, unless otherwise noted)

Parameter	Symbol	Rating	Units
Drain-to-Source Voltage	$V_{DSS}$	85	V
Gate-to-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$I_D$	$T_C=25^\circ C$	108
		$T_C=100^\circ C$	68
Pulsed Drain Current <sup>(1)</sup>	$I_{DM}$	432	A
Single Pulse Avalanche Energy <sup>(4)</sup>	$E_{AS}$	529	mJ
Power Dissipation	$T_C=25^\circ C$	$P_{tot}$	109
Junction Temperature Range	$T_j$	-55 ~ 150	°C
Storage Temperature Range	$T_{stg}$	-55 ~ 150	°C

### 4.2 Thermal Characteristics

Parameter	Symbol	Rating	Units
Thermal Resistance, Junction to Case-sink	$R_{thJC}$	1.15	°C/W

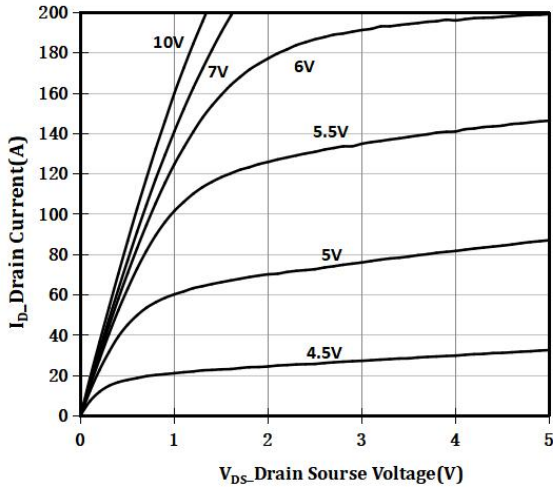
**4.3 Electrical Characteristics** (Tc=25°C, unless otherwise noted)

Parameter	Symbol	Test Condition	Value			Units
			Min	Typ	Max	
<b>Off Characteristics</b>						
Drain-to-Source Breakdown Voltage	$BV_{DSS}$	$I_D=250\mu A, V_{GS}=0V$	85	--	--	V
Drain-to-Source Leakage Current	$I_{DSS}$	$V_{DS}=80V, V_{GS}=0V, T_C=25^\circ C$	--	--	1	$\mu A$
		$V_{DS}=80V, V_{GS}=0V, T_C=125^\circ C$	--	--	100	$\mu A$
Gate-to-Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$	--	--	$\pm 100$	nA
<b>On Characteristics</b>						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2	3	4	V
Drain-to-Source on-state Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=20A$	--	4.5	5.2	m $\Omega$
<b>Dynamic Characteristics</b>						
Input Capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=45V, f=1.0MHz$	--	3958	--	pF
Output Capacitance	$C_{oss}$		--	622	--	
Reverse Transfer Capacitance	$C_{rss}$		--	10	--	
Gate Resisitance	$R_G$	$V_{DD}=0V, V_{GS}=0V, F=1MHz$	--	2.7	--	$\Omega$
<b>Switching Characteristics</b>						
Turn-on Delay Time	$t_{d(on)}$	$I_D=60A, V_{DD}=30V, V_{GS}=10V, R_{GEN}=4.7\Omega$	--	30	--	nS
Turn-on Rise Time	$t_r$		--	17	--	
Turn-off Delay Time	$t_{d(off)}$		--	52	--	
Turn-off Fall Time	$t_f$		--	20	--	
Total Gate Charge	$Q_g$	$I_D=60A, V_{DD}=45V, V_{GS}=10V$	--	50	--	nC
Gate-to-Source Charge	$Q_{gs}$		--	19	--	
Gate-to-Drain("Miller") Charge	$Q_{gd}$		--	6.8	--	
<b>Drain-Source Diode Characteristics</b>						
Diode Forward Voltage <sup>(3)</sup>	$V_{SD}$	$V_{GS}=0V, I_S=20A$	--	--	1.2	V
Diode Forward Current	$I_S$		--	--	108	A
Reverse Recovery Time <sup>(3)</sup>	$t_{rr}$	$T_J=25^\circ C, I_F=50A, di_F/dt=100A/\mu S, V_{GS}=0V$	--	70	--	nS
Reverse Recovery Charge <sup>(3)</sup>	$Q_{rr}$		--	102	--	nC

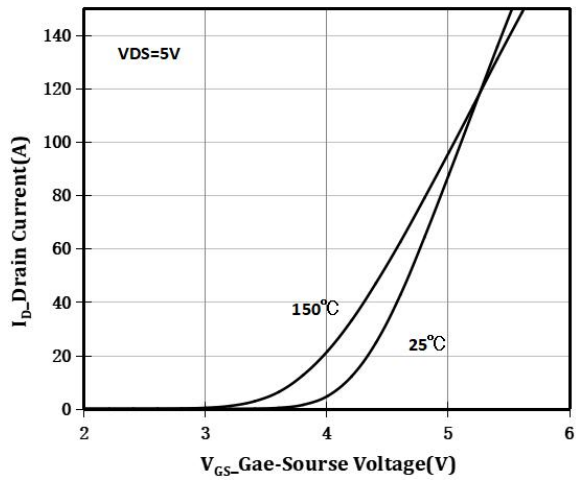
**Notes:**

- 1: Repetitive rating, pulse width limited by maximum junction temperature.
- 2: Surface mounted on FR4 Board,  $t_s \leq 10sec$ .
- 3: Pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .
- 4:  $L=0.5mH, V_{DD}=50V, V_{GATE}=85V, Start T_J=25^\circ C$ .

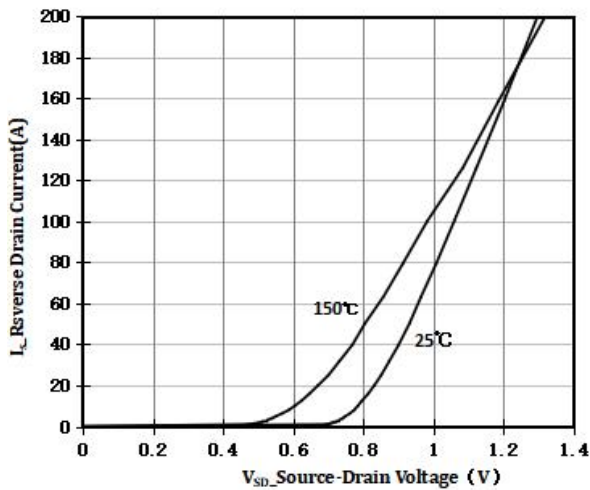
**5 Typical characteristics diagrams**



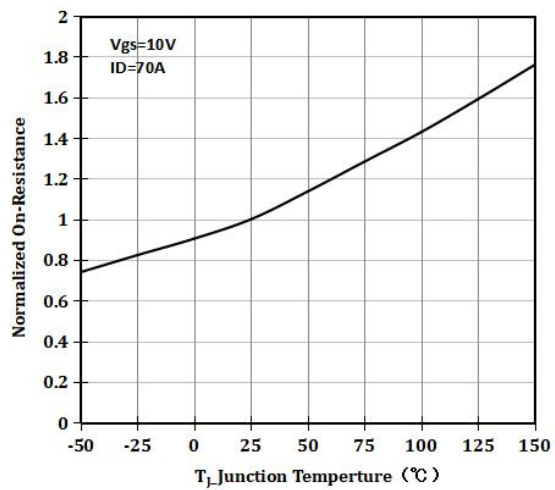
**Figure 1. Output Characteristics**



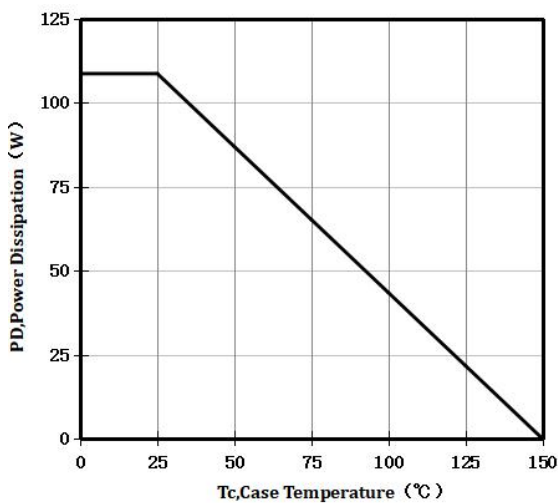
**Figure 2. Transfer Characteristics**



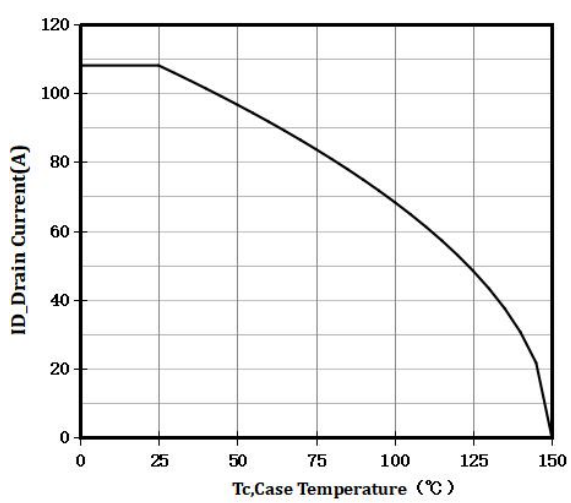
**Figure 3. Source-Drain Diode Forward**



**Figure 4. Rdson-Junction Temperature**

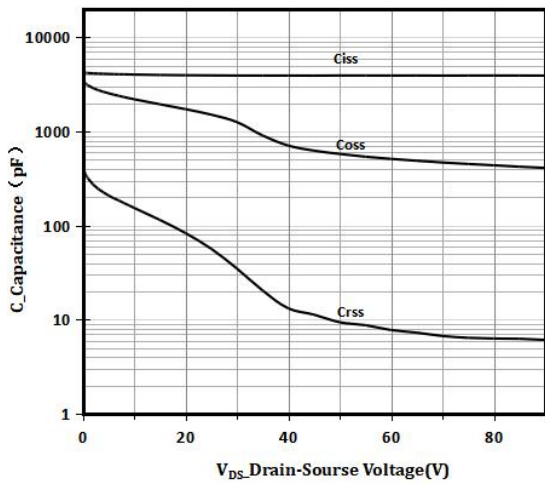


**Figure 5. Power De-rating**

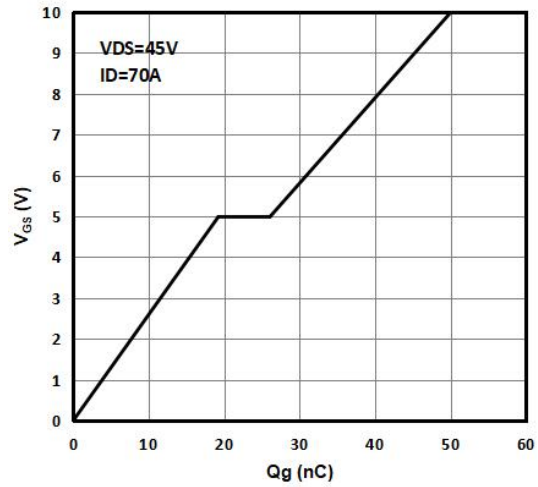


**Figure 6. Current De-rating**

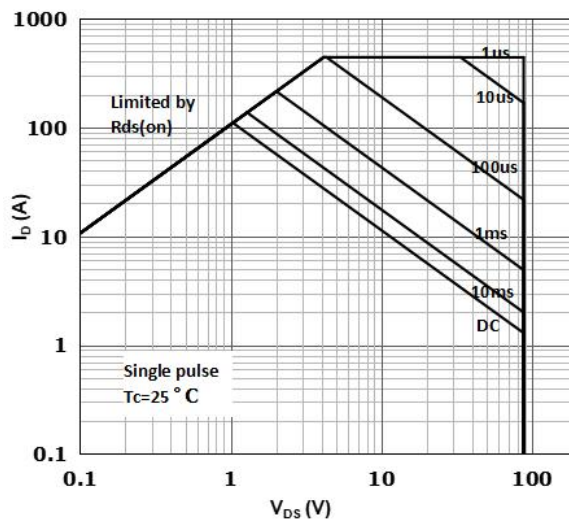
**5 Typical characteristics diagrams(continues)**



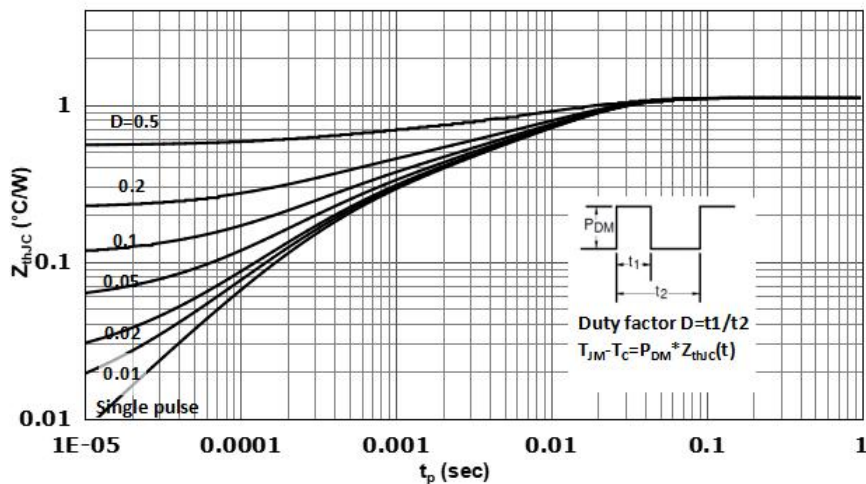
**Figure 7. Capacitance vs Vds**



**Figure 8. Gate Charge**

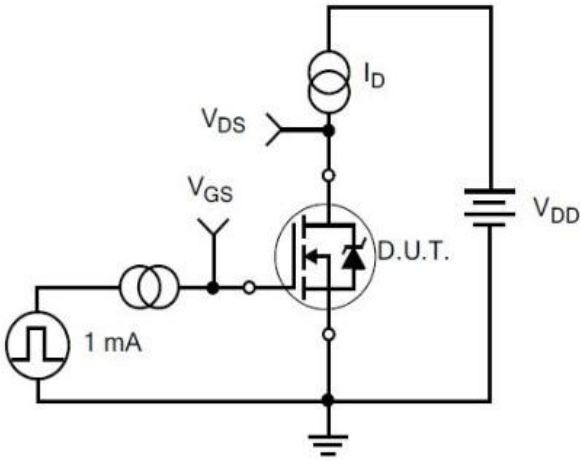


**Figure 9. SOA**

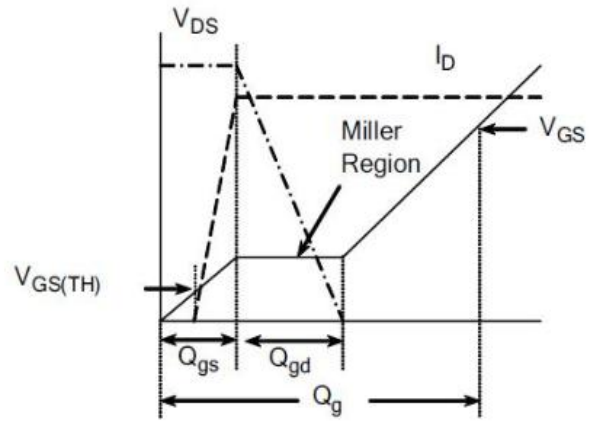


**Figure 10. Normalized Maximum Transient Thermal Impedance**

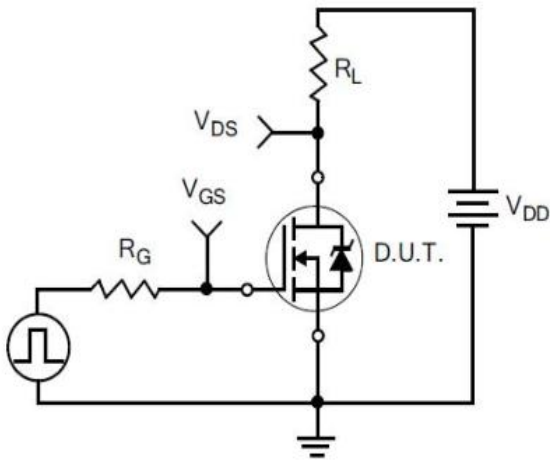
**6 Typical Test Circuit and Waveform**



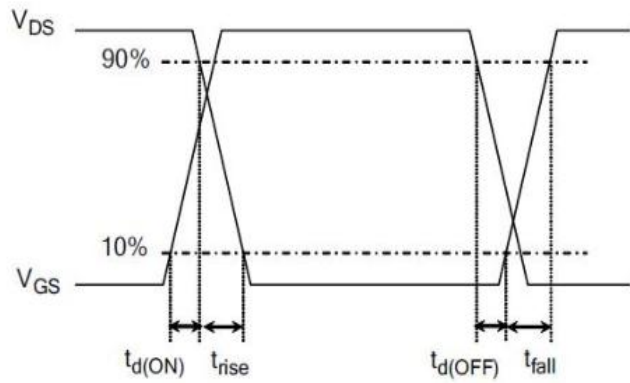
1) Gate Charge Test Circuit



2) . Gate Charge Waveform

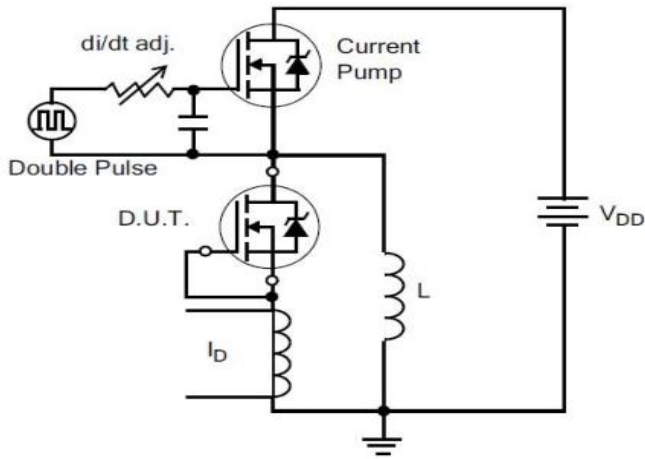


3) Resistive Switching Test Circuit

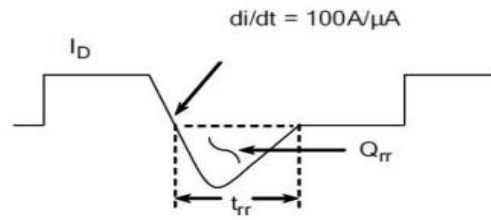


4) Resistive Switching Waveforms

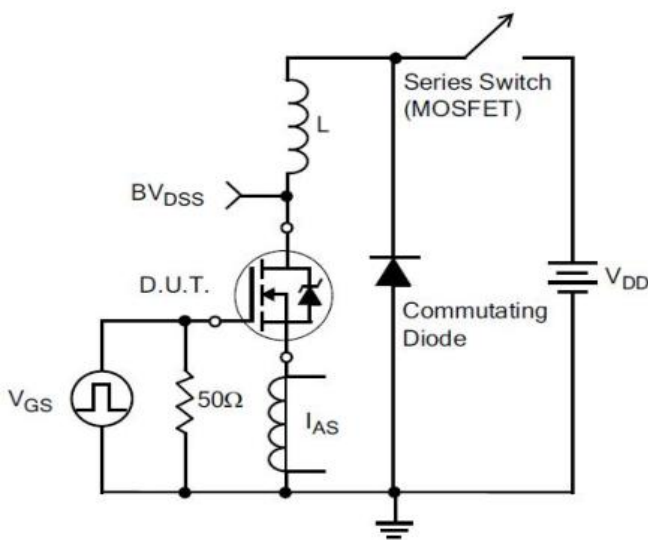
**6 Typical Test Circuit and Waveform(continues)**



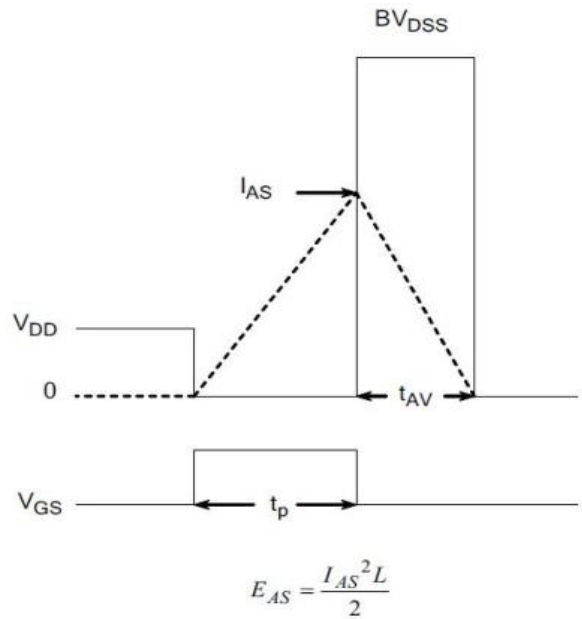
5) Diode Reverse Recovery Test Circuit



6) Diode Reverse Recovery Waveform



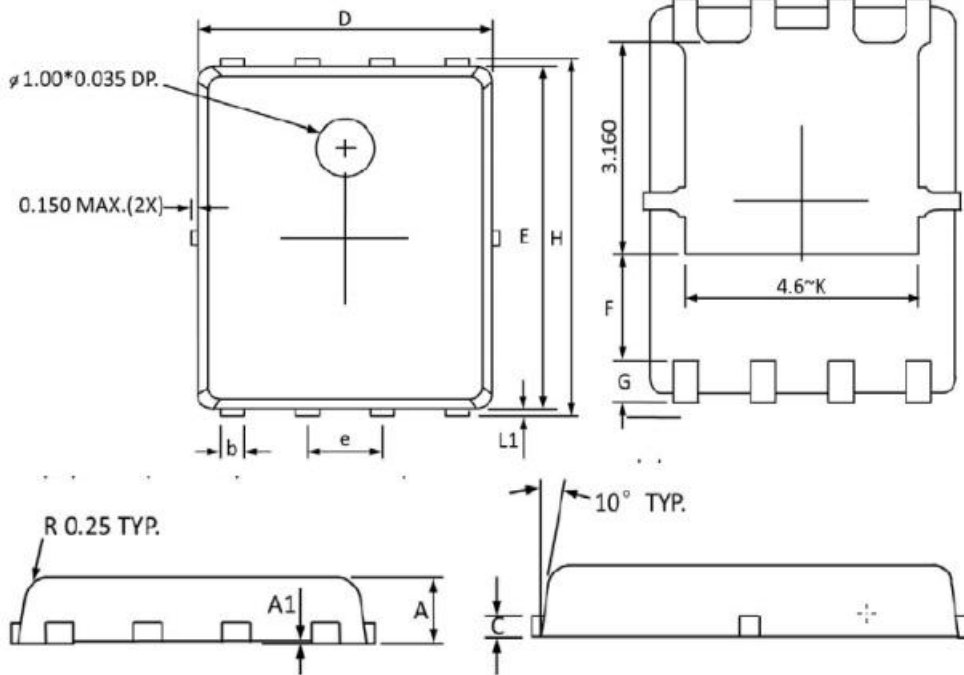
7) . Unclamped Inductive Switching Test Circuit



8) Unclamped Inductive Switching Waveforms

7 Dimensions

PPAK5x6 PACKAGE INFORMATION



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	0.800	1.000	0.032	0.039
A1	0.000	0.005	0.000	0.000
b	0.350	0.490	0.014	0.019
C	0.254 Ref		0.254 Ref	
D	4.900	5.100	0.193	0.200
E	5.700	5.900	0.225	0.232
e	1.27 BSC		1.27 BSC	
F	1.600 Ref		1.600 Ref	
G	0.600 Ref		0.600 Ref	
H	5.950	6.200	0.235	0.244
L1	0.100	0.180	0.004	0.007
K	3.200 Ref		3.200 Ref	



## 8 Product Specifications and Packaging Models

Product Model	Package Type	Mark Name	RoHS	Package	Quantity
DHS042N85P	DFN5*6-8	DHS042N85P	Pb-free	Tape & Reel	3000/box

## 9 Attentions

- Jiangsu Donghai Semiconductor Technology CO.,LTD. reserves the right to change the specification without prior notice! The customer should obtain the latest version of the information before making the order and verify that the information is complete and up to date.
- It is the responsibility of the purchaser for any failure or failure of any semiconductor product under certain conditions. It is the responsibility of the purchaser to comply with safety standards and to take safety measures in the system design and machine manufacturing of Donghai products in order to avoid potential risk of failure. Injury or property damage.
- Product promotion is endless, our company will be dedicated to provide customers with better products.

## 10 Appendix

Revision history:

Date	REV.	Description	Page
2019.10.19	1.0	Original	10
2023.7.25	2.0	Update	10